# Printing of Electrical Functional structures using additive technologies

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# Outline

- 1. Technologies / Materials / Process Flow
  - 1. Aerosol-Jet-Deposition & Screen Printing
  - 2. Paste formulation for screen printing and application example
- 2. Selected R&D topics
- 3. Further Application examples
- 4. Further printing capabilities







Aerosol-Jet-Printing Deposition Technology for Nanoparticle inks

## **Equipment @ ENAS**

- Customized Optomec AJ300 System
- 300 x 300 mm x-y-Vacuum stage
- Print Speed: max. 200 mm/s
- <u>2 Atomizer systems:</u>
  - 2 x Pneumatic Atomizer incl. Mixing option
    - [1cP 1000cP]
  - Ultrasonic Atomizer
    - [1cP 5cP, from 1ml Fluid]
- 200°C Substrate heater
- Min. line width 10 μm to 20 μm
- Laser-Curing-System included [IR Laser, 700mW, 830nm] and material mixing option



Fig 1: Aerosol-Jet 300 System @ Fraunhofer ENAS





Aerosol-Jet-Printing General Work Flow



Fig 2: General Workflow overview

A & B: Producing Aerosol by A: Ultrasonic or B: Pneumatic Atomizer Systeme

C: Focusing Material Beam in printhead and direct maskless deposition on substrate







Aerosol-Jet-Printing General Work Flow



Height above Substrate (mm)

Fig 3: Focused material beam over several millimeters enables deposition on 3D substrates without moving z-axes, diagram shows constant line width between 1mm to 3mm distance between printhead and substrate [Source: Optomec]



Fig 4: Examples for Ag deposition on 3D surfaces [deep etched cavities in Si Wafers]









Screen Printing General Work Flow



- Screen mask works as stencil
- Mesh made from polymers or metalls
- Screen openings represent printable pattern
- Squeege transfers paste through screen openings onto substrate







## Screen Printing Equipment

### Reprint R29 Spectrum

- Screen frame: 736 x 736 mm (29"x 29") to 736 x 812 mm (29" x 32")
- Camera alignment
- Fully automated vision system
- Registration +/- 10 µm



## **DEK Horizon 03iX**

- Screen frame: 736 x 736mm (29" x 29") standard
- Printable Area (510mm x 508.5mm)
- Modul for Via Filling
- Modul for Dispensing
- Vector Guard stencil printing
- Machine Alignment >2 Cpk @ +/- 12.5µm, 6 Sigma
- Process Alignment >2 Cpk @ +/- 25µm, 6 Sigma #



## Morphology: Lateral 50 µm - 150 mm; Vertical 10 µm - 1 mm









Metal Nanoparticle Inks Overview Sintering Process

#### Nanoparticle Inks – Post-treatment and sintering

- Suspensions of metal particles in solvents
- Pretreatment for dense layer and electrical conductivity:
  - Drying out solvents, burning out organic shells, sintering



Fig 3: Nanoparticle filled Ink, Drying out solvents, burning out organic shells, sintering

#### Sintering without pressure

• Particle necking due to diffusion effects





#### **Experimental Setup**

Sintering of Ag Nanoparticles and SEM investigation at different temperature steps



Fig 5: SEM Investigation - Sintering of Ag Nanoparticles and grain size at 60°C, 100°C, 200°C, 250°C, 300°C



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Paste formulation for Screenprinting

## Paste Particle characterization







## Paste manufacturing and characterization





Application test magnetic pastes









Paste formulation for Screen printing

SEM image of NdFeB particles

Using magnetic paste for screen printing a MEMS speaker (electromagnetic actuation) was demonstrated

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Mikrotechnologien

Metallic glass membrane

**Magnetic paste** 

## **1. Printed RDLs for polymer substrates**

### Concept

Printing conductive fine pitch multilayers for a variety of substrates materials enable smart systems

### Needed:

•Fine pitch, 3D ready deposition process for conductive materials

•Conformal dielectric coating technology for 3D substrates

•Process for via fabrication to enable multilayers

Low temperature processes < 150°C to enable the usage of sensitive / polymer / low cost substrates









1. Printed RDLs for polymer substrates

## **Motivation for Parylene:**

- Deposition at ambient temperatures (no thermal stresses)
- Pinhole-free at d > 0,2µm
- Uniform layer thickness, in particular at edges, excellent gap penetration
- No solvent or catalyst required
- Yield of 100% monomer above 550°C in vacuum (using [2,2]p-cyclophane)
- No by-products
- Batch process for high throughput
- Bio compatible medicine products



Plasma Parylene LC 300 RW (Plasma Parylene Systems – PPS)



Parylene = Poly(p-xylylene)

## **Gorham Process**

- 3 step deposition
- Polymerization @ Roomtemperature (condensation)









**1. Printed RDLs for polymer substrates** 

## **Parylene Properties**

- Conformal coating on Waferlevel < 10% thickness variation developed
- Conformal coating for high aspect ratio patterns
- Highly transparent
- Ar plasma pretreatment enables printing process
- Good moisture barrier

Properties of Parylene C	
Melting point	290°C
Temperature stability	125°C
Peak Temperature	200°C
Water absorption in 24h	0,06%











1. Printed RDLs for polymer substrates









**1. Printed RDLs for polymer substrates** 









1. Printed RDLs for polymer substrates

Laser Ablation of Parylene on top of printed Ag

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## **FIB Cross Section**



## **FIB Cross Section Investigation**

- Conformal Parylene Coating
- No Ag ablation visible
- Sidewall effects of laser ablation visible
- → Parylene thickness increasing
- → Some defects near Parylene sidewall visible







## **1. Printed RDLs for polymer substrates**

## Via Results

2<sup>nd</sup> layer Ag printing to fill vias, sintering

+

## **Electrical Testing**

- Via resistance [50µmx200µm] < 10 Ω after fabrication
- Thermal cycling (-55/125°C,30min) performed

 $\rightarrow$  After >300cycles resistance is stable with around 5  $\Omega$  / Interconnect due to additional sintering









**1. Low temperature Wafer level Bonding using metal nanoparticles** 



Si Wafer with Au adhesion promoter and printed Ag Bondframes

schematic process flow







1. Low temperature Wafer level Bonding using metal nanoparticles



**FIB&SEM** investigations at the Interface Au-Ag-Au, 250°C: Ag layer is fully wetting the Au adhesion promoter, porous interface

**FIB&SEM investigations at the Interface Au-Ag-Au, 250°C:** Ag layer is fully wetting the Au adhesion promoter, pore size increasing, diffusion Au – Ag visible using EDX

**Conclusion for all bonds** (for all temperatures 350°C to 200°C and Au / Cu adhesion layer) today→ hermetic sealing using Ag Nanoparticle intermediate layer not possible but mechanical bond is succesful

**Reasons:** porous interface and inhomogeneous thickness of Bondframe due to printing process at start and endpoint of printed microstructures







**1. Low temperature Wafer level Bonding using metal nanoparticles** 

Analogue process was developed for screen printing technology using Au Nanoparticles:

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- Applied bond pressure 6.5kN
- Bonding Temperature 200°C ٠
- → High densification within the Bondframe
- $\rightarrow$  100% yield after dicing
- $\rightarrow$  Hermeticity evaluations ongoing





# **4. Further Application Scenarios**

using 3D suitable deposition technology for Nanoparticle Inks



**Printed Sensors (Au Nanoparticles)** on low cost substrates



High density 3D MID Substrates by additive manufacturing



**Printed Interconnects for stacked** components

Ovic

Silber Nanopartikel



**Flexible Electronics** 



Joining (WLB and CLP) using Nanoparticle intermediate layers – low sintering temperature enables Bonding < 250°C



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Au

Ovic

# 4. Further printing capabilities

upscaling and R2R manufacturing (i.e. printed RFID Antennas)



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# 4. Further printing capabilities

institute for print and media technologies TUC

# ...this is what we do: Printing beyond color – printed functionalities











Printed antennas – planar and 3D Printed batteries Printed

**Printed sensors** 

**Printed transistors** 



[a) Hammerschmidt et al., Langmuir 28, 2012; b) Belgardt et al., Phys. Chem. Chem. Phys. 15, 2013; c) Sowade et al., Adv. Eng. Mat. 14, 2012; Sowade et al., Cryst. Growth Des. 16, 2016; d) Zichner et al., Jpn. J. Appl. Phys. 53, 2014; Kang et al., Appl. Mater. Interfaces 6, 2014; Sowade et al., J. Mater. Chem. C. 3, 2015; d) Marjanovic et al., J. Mater. Chem. 21, 2011; e) Lorwongtragool et al., Sensors 14, 2014; Dinh et al., Carbon 96, 2016; f) Castro et al., Journal of Electronic Materials 7, 2014; g) Sowade et al., Organic Electronics 30, 2016]



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# Thank you for the kind attention

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Fraunhofer ENAS Department System Packaging Technologie Campus 3 09126 Chemnitz Germany We would be pleased to cooperate with you in European or German national projects as well as direct cooperation and technology transfer

#### Service offers:

- Paste/Ink formulation screen printing and Aerosol-Jet
- Testing of inks/pastes (printability, electricaly, reliability, adhesion,..)
- Design and feasibility studies
- Workshops and training to enable technology transfer





